



Sheet 1 of 1

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

960569C

SERIAL NO.

09/227,529

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT

Toshimitsu KUMAGAI, et al.

FILING DATE

January 8, 1999

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2876

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	5,406,063	4/11/95	JELEN	235	472	5/7/93
	AB	5,107,100	4/21/92	SHEPARD, ET AL.	235	472	11/8/90
	AC	3,718,783	2/27/73	KEMENCZKY	200	1	6/25/71
	AD	5,475,207	12/12/95	BOBBA, ET AL.	235	467	11/19/93
	AE	5,231,277	7/27/93	ARITAKE, ET AL.	235	462	5/29/92

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
	AF	EP 0 460 699 A	12/11/91	Europe			X	
	AG	EP 0 653 723 A	05/17/95	Europe			X	
	AH	GB 1 487 431 A	09/28/77	UK			X	
	AI	EP 0 543 649 A2	05/26/93	Europe			X	
	AJ							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AK	Patent Abstracts of Japan vol. 018, no. 247 (P-1735), 11 May 1994 and JP 06 028508 A (FUJITSU LTD), 4 February 1994, Abstract; Figures & US 5 693 930 A (H. KATOH ET AL.) 2 December 1997.
	AL	Patent Abstracts of Japan vol. 017, no. 619 (P-1644), 15 November 1993 and JP 05 196855 A (RICOH CO LTD), 6 August 1993.
	AM	

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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
<i>[initials]</i>	AA	5,528,024	06/18/96	Rockstein, et al.	235	462	
	AB	5,458,951	11/21/95	Knowles, et al.	235	462	
	AC	4,652,732	03/24/87	Nickl	235	462	
	AD	5,594,228	01/14/97	Swartz, et al.	235	462	
	AE	5,591,953	01/07/97	Rockstein, et al.	235	462	
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	AG	5,231,277	07/27/93	Aritake, et al.	235	462	
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	AI	2,214,270	05/25/93	Rando	235	462	
	AJ	5,693,930	12/02/97	Kato, et al.	235	462	
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	AM	5,235,167	08/10/93	Dvorkis, et al.	235	462	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO
<i>[initials]</i>	AN	6-28508	2/4/94	Japan			Partial
	AO	EP 0 460 669	12/11/91	EPO			Yes

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	
	AR	

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